# Si8806DB

RoHS

COMPLIANT

HALOGEN



**Vishay Siliconix** 

## N-Channel 12 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (TYP.)			
	0.047 at V <sub>GS</sub> = 4.5 V	3.9				
12	0.055 at V <sub>GS</sub> = 2.5 V	3.6	6.5 nC			
	0.075 at V <sub>GS</sub> = 1.8 V	3.2				

### MICRO FOOT® 0.8 x 0.8





Marking Code: xx = AD

xxx = Date/Lot traceability code

Ordering Information:

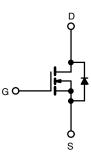
Si8806DB-T2-E1 (lead (Pb)-free and halogen-free)

#### FEATURES

- TrenchFET<sup>®</sup> power MOSFET
- Small 0.8 mm x 0.8 mm outline area
- Low 0.4 mm max. profile
- Low On-resistance
- Material categorization: for definitions of 
  compliance please see <u>www.vishay.com/doc?99912</u>

#### **APPLICATIONS**

- · Load switch with low voltage drop
- Load switch for low voltage power lines
- Smart phones, tablet PCs, mobile computing



N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	<b>S</b> (T <sub>A</sub> = 25 °C, u	Inless otherwi	ise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	12	V
Gate-Source Voltage		V <sub>GS</sub>	± 8	v
	T <sub>A</sub> = 25 °C		3.9 <sup>a</sup>	
Continuous Drain Current (T. 150 °C)	T <sub>A</sub> = 70 °C	Ι. Γ	3.1 <sup>a</sup>	
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	2.8 <sup>b</sup>	
	T <sub>A</sub> = 70 °C	1 [	2.3 <sup>b</sup>	A
Pulsed Drain Current (t = 300 µs)		I <sub>DM</sub>	20	
	T <sub>A</sub> = 25 °C		0.7 ª	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.4 <sup>b</sup>	
	T <sub>A</sub> = 25 °C		0.9 <sup>a</sup>	
Mauianum Dauran Diagingtian	T <sub>A</sub> = 70 °C		0.6 <sup>a</sup>	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.5 <sup>b</sup>	W
	T <sub>A</sub> = 70 °C	1 [	0.3 <sup>b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Soldering Recommendations (Peak Temperature) <sup>c</sup>			260	

THERMAL RESISTANCE RATING	RMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient a, d	t < 5 o	Р	105	135	°C/W	
Maximum Junction-to-Ambient <sup>b, e</sup>	t≤5s	R <sub>thJA</sub>	200	260	0/10	

#### Notes

a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.

- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.

d. Maximum under steady state conditions is 185 °C/W.

e. Maximum under steady state conditions is 330 °C/W.

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## Si8806DB

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PARAMETER	SYMBOL TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	12	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA	-	6	-	mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i <sub>D</sub> = 250 μA	-	-2.9	-		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.4	-	1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V$ , $V_{GS} = \pm 8 V$	-	-	± 100	nA	
Zero Gate Voltage Drain Current		$V_{DS} = 12 V, V_{GS} = 0 V$	-	-	1		
Zero Gale voltage Drain Gurrent	I <sub>DSS</sub>	$V_{DS}$ = 12 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C	-	-	10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \geq 5 \text{ V},  V_{GS} = 4.5 \text{ V}$	10	-	-	A	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 1 \text{ A}$	-	0.035	0.047		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 1 \text{ A}$	-	0.039	0.055	Ω	
	- ( - )	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.5 A	-	0.047	0.075		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 6 V, I_D = 1 A$	-	16	-	S	
Dynamic <sup>b</sup>							
Total Gate Charge	0	$V_{DS} = 6 V, V_{GS} = 8 V, I_D = 1 A$	-	11	17		
Total Gate Charge	Qg		-	6.5	10	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 6 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$	-	0.9	-		
Gate-Drain Charge	Q <sub>gd</sub>	-		1.6	-		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	-	6	-	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	10	20		
Rise Time	t <sub>r</sub>	$V_{DD} = 6 V, R_L = 6 \Omega$	-	20	40		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, \text{ R}_g = 1 \Omega$	-	30	60		
Fall Time	t <sub>f</sub>		-	12	25	- ns	
Turn-On Delay Time	t <sub>d(on)</sub>		-	7	15		
Rise Time	t <sub>r</sub>	$V_{DD} = 6 V, R_L = 6 \Omega$	-	16	35		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1$ A, $V_{GEN}$ = 8 V, $R_g$ = 1 $\Omega$	-	25	50	1	
Fall Time	t <sub>f</sub>		-	9	20	1	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>A</sub> = 25 °C	-	-	0.7	^	
Pulse Diode Forward Current	I <sub>SM</sub>		-	-	20	A	
Body Diode Voltage	V <sub>SD</sub>	$I_{\rm S} = 1$ A, $V_{\rm GS} = 0$ V	-	0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	20	40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	5	10	nC	
Body Didde Hotolog Hotolog Hotolog      diff        Reverse Recovery Fall Time      ta		I <sub>F</sub> = 1 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C	-	5	-		
Reverse Recovery Rise Time	t <sub>b</sub>	1	-	15	İ	ns	

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

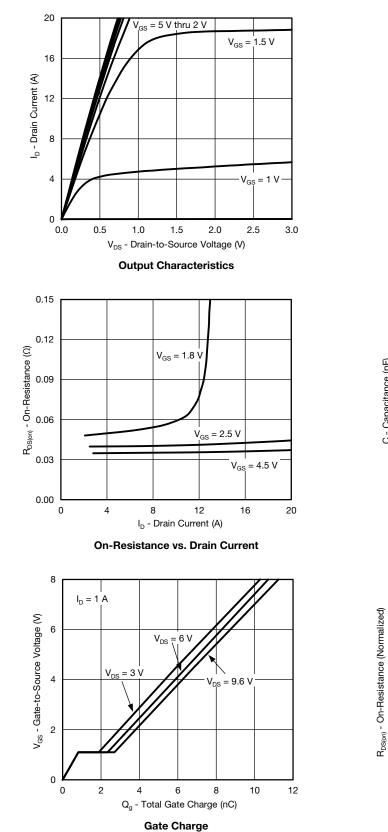
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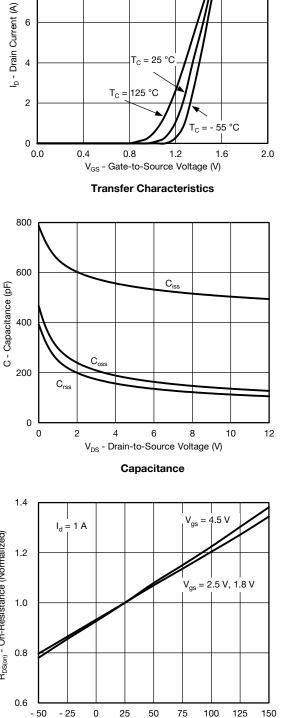


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

10

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T<sub>J</sub> - Junction Temperature (°C)

**On-Resistance vs. Junction Temperature** 

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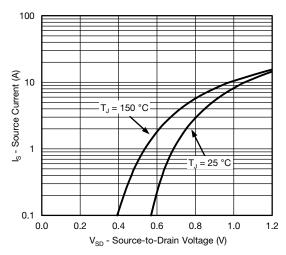
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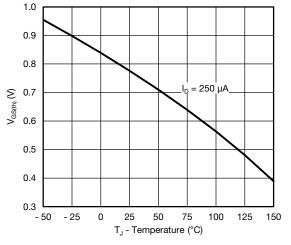
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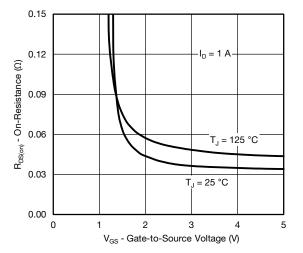
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



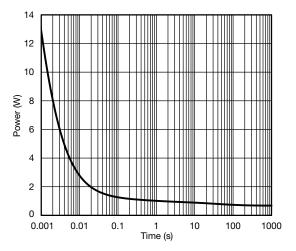
Source-Drain Diode Forward Voltage



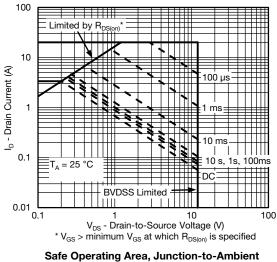




**On-Resistance vs. Gate-to-Source Voltage** 



Single Pulse Power (Junction-to-Ambient)

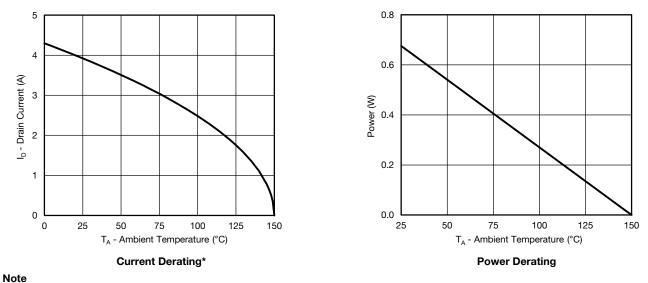




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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



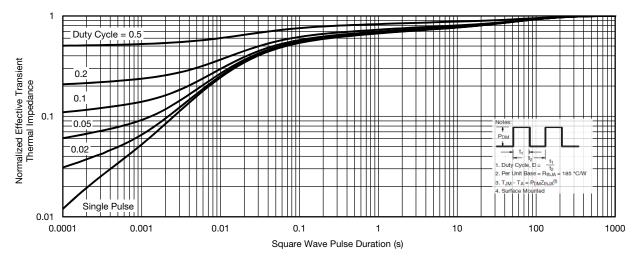
When mounted on 1" x 1" FR4 with full copper.

\* The power dissipation  $P_D$  is based on  $T_J$  (max.) = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

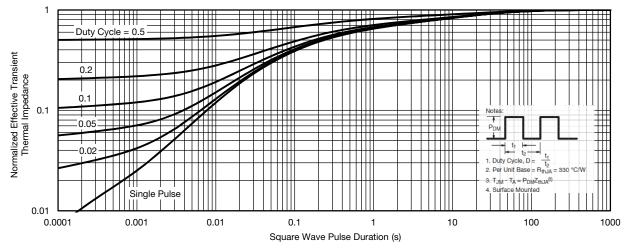




### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Maximum Copper)

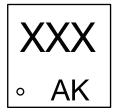


Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Minimum Copper)

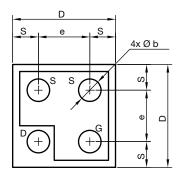
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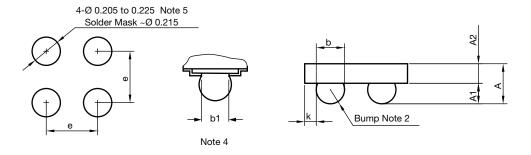


## MICRO FOOT®: 4-Bump (0.8 mm x 0.8 mm, 0.4 mm Pitch)









#### Notes

<sup>(1)</sup> Laser mark on the backside surface of die

<sup>(2)</sup> Bumps are 95.5 % Sn,3.8 % Ag,0.7 % Cu

<sup>(3)</sup> "i" is the location of pin 1

<sup>(4)</sup> "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.

<sup>(5)</sup> Non-solder mask defined copper landing pad.

DIM.	MILLIMETERS <sup>a</sup>			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
А	0.328	0.365	0.402	0.0129	0.0144	0.0158
A1	0.136	0.160	0.184	0.0053	0.0062	0.0072
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086
b	0.200	0.220	0.240	0.0078	0.0086	0.0094
b1	0.175			0.0068		
е		0.400		0.0157		
S	0.160	0.180	0.200	0.0062	0.0070	0.0078
D	0.720	0.760	0.800	0.0283	0.0299	0.0314
К	0.040	0.070	0.100	0.0015	0.0027	0.0039

#### Note

a. Use millimeters as the primary measurement.

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